


Search Notes 	Application/Control No. 10551817	Applicant(s)/Patent Under Reexamination LIN ET AL.
	Examiner Cheng, Ichieh	Art Unit 4183

SEARCHED			
Class	Subclass	Date	Examiner
455	560,442,449,552.1,331,440,437,456.1.445,438,439	03/03/2008	Ichieh Cheng
370	349,338,329,412,389,469,395.2,236,428,351,436,395.21,401	03/03/2008	Ichieh Cheng

SEARCH NOTES		
Search Notes	Date	Examiner
Text search attached	03/03/2008	Ichieh Cheng

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner